Shenzhen CTA Testing Technology Co., Ltd.



Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

FCC PAR	T 15 SUBPART C TEST REPORT
	FCC PART 15.247
Report Reference No	CTA24122300401 2A8ZO-X62
(position+printed name+signature) .:	File administrators Xudong Zhang
Supervised by position+printed name+signature) .:	Project Engineer Zoey Cao
Approved by (position+printed name+signature) .:	RF Manager Eric Wang
Date of issue	Jan. 03, 2025
Testing Laboratory Name	Shenzhen CTA Testing Technology Co., Ltd.
Address:	Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community Fuhai Street, Baoʻan District, Shenzhen, China
Applicant's name	Shenzhen Xianlong Technology Co., Ltd.
Address	4F Building 5, Lantian Science and Technology Park Sha'er, Shajin Baoan District, Shenzhen, Guangdong, China
est specification:	TATESIN
Test specification Standard	FCC Part 15.247
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Shenzhen CTA Testing Technology Co., Ltd.

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	TESTING	TEST REPORT	
	CIP	CTING	
	Equipment under Test :	Speaker	
	Model /Type :	Speaker X62	
	Listed Models :	A62	CES CTA
27	Model difference :	The PCB board, circuit, structure and internal of same, Only model number and colour is different	
	Applicant :	Shenzhen Xianlong Technology Co., Ltd.	TING
	Address :	4F Building 5, Lantian Science and Technology Baoan District, Shenzhen, Guangdong, China	Park Sha'er, Shajing
	Manufacturer :	Shenzhen Xianlong Technology Co., Ltd.	
Ð	Address :	4F Building 5, Lantian Science and Technology Baoan District, Shenzhen, Guangdong, China	Park Sha'er, Shajing

Test Result:

PASS

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test CTA TESTIN laboratory.

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GA CTATESTING

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1 <u>TEST STANDARDS</u>

The tests were performed according to following standards:

CTA TESTING

<u>FCC Rules Part 15.247</u>: Frequency Hopping, Direct Spread Spectrum and Hybrid Systems that are in operation within the bands of 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz. <u>ANSI C63.10-2013</u>: American National Standard for Testing Unlicensed Wireless Devices

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GA CTATESTING

2 SUMMARY

2.1 General Remarks

Date of receipt of test sample	1º	Dec. 23, 2024
	(COP	
Testing commenced on		Dec. 23, 2024
Testing concluded on	:	Jan. 03, 2025

2.2 Product Description

Testing commenced on	: Dec. 23, 2024
Testing concluded on	: Jan. 03, 2025
2.2 Product Descrip	otion 🕐
Product Name:	Speaker
Model/Type reference:	X62
Power supply:	DC 7.4V From battery and DC 5.0V From external circuit
Hardware version:	V1.0
Software version:	V1.0
Testing sample ID:	CTA241223004-1# (Engineer sample) CTA241223004-2# (Normal sample)
Bluetooth :	
Supported Type:	Bluetooth BR/EDR
Modulation:	GFSK, π/4DQPSK, 8DPSK
Operation frequency:	2402MHz~2480MHz
Channel number:	79
Channel separation:	1MHz
Antenna type:	PIFA antenna
Antenna gain:	0.88 dBi

2.3 Equipment Under Test

Power supply system utilised

Power supply voltage	:	0	230V / 50 Hz	0	120V / 60Hz	7
(64)		0	12V DC	Ο	24V DC	
			Other (specified in blank be	low)	OIN
<u>DC 7.4</u>	/ Fror	n ba	attery and DC 5.0V From exte	erna	al circuit	
2.4 Short description of t	he E	qui	pment under Test (EU ⁻	T)	(31)	

Short description of the Equipment under Test (EUT) 2.4

This is a Speaker.

For more details, refer to the user's manual of the EUT.

GA CTATESTING

2.5 **EUT** configuration

The following peripheral devices and interface cables were connected during the measurement:

supplied by the manufacturer

\odot - supplied by the lab

Ο Adapter Model: EP-TA20CBC Input: AC 100-240V 50/60Hz Output: DC 5V 2A

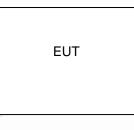
2.6 EUT operation mode

The Applicant provides communication tools software(AT command) to control the EUT for staying in continuous transmitting (Duty Cycle more than 98%) and receiving mode for testing . There are 79 channels TESTING provided to the EUT and Channel 00/39/78 were selected to test.

Operation Frequency:

	Frequency (MHz)
00	2402
01	2403
	:
38	2440
39	2441
40	2442
TATES	36
77	2479
78	2480

Block Diagram of Test Setup 2.7



DC 5.0V From adapter

TATESTING

Related Submittal(s) / Grant (s) 2.8

This submittal(s) (test report) is intended for the device filing to comply with Section 15.247 of the FCC Part 15, Subpart C Rules.

2.9 **Modifications**

No modifications were implemented to meet testing criteria. GTA TESTING

3 TEST ENVIRONMENT

3.1 Address of the test laboratory

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

3.2 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement

CAB identifier: CN0127 ISED#: 27890

Shenzhen CTA Testing Technology Co., Ltd. has been listed by Innovation, Science and Economic Development Canada to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

3.3 Environmental conditions

CTA TESTING During the measurement the environmental conditions were within the listed ranges: Radiated Emission:

I.	\ac	110	יוג	J	L	_ !	11	10	5	1.
	-									

Temperature:	24 ° C
Humidity:	45 %
Atmospheric pressure:	950-1050mbar

AC Power Conducted Emission:

Temperature:	25 ° C	
Liumiditu:	46.0/	-
Humidity:	46 %	STING
Atmospheric pressure:	950-1050mbar	TATES
conducted testing:	Get S	
Temperature:	25 ° C	7

Conducted testina:

onduotod tooting.	
Temperature:	25 ° C
Humidity:	44 %
Atmospheric pressure:	950-1050mbar
TATESIN	
CTATEST	TESTIN
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3.4 Summary of measurement results

	Test Specification clause	Test case	Test Mode	Test Channel		orded eport	Test result
	§15.247(a)(1)	Carrier Frequency separation	GFSK N/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	GFSK N/4DQPSK 8DPSK	🖾 Middle	Compliant
	§15.247(a)(1)	Number of Hopping channels	GFSK Π/4DQPSK 8DPSK	🛛 Full	GFSK	🛛 Full	Compliant
	§15.247(a)(1)	Time of Occupancy (dwell time)	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	GFSK Π/4DQPSK 8DPSK	X Middle	Compliant
CTATE	§15.247(a)(1)	Spectrumbandwidth of aFHSS system20dB bandwidth	GFSK ∏/4DQPSK 8DPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK Π/4DQPSK 8DPSK	☑ Lowest☑ Middle☑ Highest	Compliant
	§15.247(b)(1)	Maximum output peak power	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	GFSK Π/4DQPSK 8DPSK	⊠ Lowest ⊠ Middle ⊠ Highest	Compliant
	§15.247(d)	Band edgecompliance conducted	GFSK Π/4DQPSK 8DPSK	⊠ Lowest ⊠ Highest	GFSK Π/4DQPSK 8DPSK	⊠ Lowest ⊠ Highest	Compliant
G	§15.205	Band edgecompliance radiated	GFSK Π/4DQPSK 8DPSK	⊠ Lowest ⊠ Highest	GFSK Π/4DQPSK 8DPSK	☑ Lowest☑ Highest	Compliant
	§15.247(d)	TX spuriousemissions conducted	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	Compliant
	§15.247(d)	TX spuriousemissions radiated	GFSK Π/4DQPSK 8DPSK	Lowest Middle	GFSK	 ☑ Lowest ☑ Middle ☑ Highest 	Compliant
	§15.209(a)	TX spurious Emissions radiated Below 1GHz	GFSK ∏/4DQPSK 8DPSK	⊠ Lowest ⊠ Middle ⊠ Highest	GFSK	Middle	Compliant
	§15.107(a) §15.207	Conducted Emissions 9KHz-30 MHz	GFSK Π/4DQPSK 8DPSK	 ☑ Lowest ☑ Middle ☑ Highest 	GFSK	🛛 Middle	Compliant

Remark: The measurement uncertainty is not included in the test result.

3.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 2 " and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device. Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd. :

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	9KHz~30MHz	3.02 dB	(1)
Radiated Emission	30~1000MHz	4.06 dB	(1)
Radiated Emission	ated Emission 1~18GHz		(1)
Radiated Emission	18-40GHz	5.38 dB	(1)
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)
Output Peak power	30MHz~18GHz	0.55 dB	(1)
Power spectral density	1	0.57 dB	(1)
Spectrum bandwidth	/	1.1%	(1)

Radiated spurious emission (30MHz-1GHz)	30~1000MHz	4.10 dB	(1)
Radiated spurious emission (1GHz-18GHz)	1~18GHz	4.32 dB	(1)
Radiated spurious emission (18GHz-40GHz)	18-40GHz	5.54 dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.6 Equipments Used during the Test

		-				
	Test Equipment	Manufacturer	Model No.	Equipment No.	Calibration Date	Calibration Due Date
ATE	LISN	R&S	ENV216	CTA-308	2024/08/03	2025/08/02
	LISN	R&S	ENV216	CTA-314	2024/08/03	2025/08/02
	EMI Test Receiver	R&S	ESPI	CTA-307	2024/08/03	2025/08/02
	EMI Test Receiver	R&S	ESCI	CTA-306	2024/08/03	2025/08/02
	Spectrum Analyzer	Agilent	N9020A	CTA-301	2024/08/03	2025/08/02
	Spectrum Analyzer	R&S	FSU	CTA-337	2024/08/03	2025/08/02
	Vector Signal generator	Agilent	N5182A	CTA-305	2024/08/03	2025/08/02
	Analog Signal Generator	R&S	SML03	CTA-304	2024/08/03	2025/08/02
	WIDEBAND RADIO COMMUNICATION TESTER	CMW500	R&S	CTA-302	2024/08/03	2025/08/02
	Temperature and humidity meter	Chigo	ZG-7020	CTA-326	2024/08/03	2025/08/02
	Ultra-Broadband Antenna	Schwarzbeck	VULB9163	CTA-310	2023/10/17	2026/10/16
-21	Horn Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2023/10/13	2026/10/12
715	Loop Antenna	Zhinan	ZN30900C	CTA-311	2023/10/17	2026/10/16
	Horn Antenna	Beijing Hangwei Dayang	OBH100400	CTA-336	2023/10/17	2026/10/16
	Amplifier	Schwarzbeck	BBV 9745	CTA-312	2024/08/03	2025/08/02
	Amplifier	Taiwan chengyi	EMC051845B	CTA-313	2024/08/03	2025/08/02
	Directional coupler	NARDA	4226-10	CTA-303	2024/08/03	2025/08/02
	High-Pass Filter	XingBo	XBLBQ-GTA18	CTA-402	2024/08/03	2025/08/02
	High-Pass Filter	XingBo	XBLBQ-GTA27	CTA-403	2024/08/03	2025/08/02
	Automated filter bank	Tonscend	JRUQI-MH8R06- F	CTA-404	2024/08/03	2025/08/02
	Power Sensor	Agilent	U2021XA	CTA-405	2024/08/03	2025/08/02
	Amplifier	Schwarzbeck	BBV9719	CTA-406	2024/08/03	2025/08/02



CTA TESTING

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Test Equipment	Manufacturer	Model No.	Version number	Calibration Date	Calibration Due Date	
EMI Test Software	Tonscend	TS®JS32-RE	5.0.0.2	N/A	N/A	
EMI Test Software	Tonscend	TS®JS32-CE	5.0.0.1	N/A	N/A	
RF Test Software	Tonscend	TS®JS1120-3	3.1.65	N/A	N/A	
RF Test Software	Tonscend	TS®JS1120	3.1.46	N/A	N/A	TE
STING					G	Jun 1

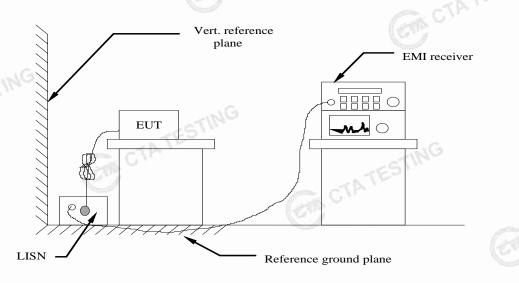
Shenzhen CTA Testing Technology Co., Ltd. Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

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4 TEST CONDITIONS AND RESULTS

4.1 AC Power Conducted Emission

TEST CONFIGURATION



TEST PROCEDURE

1 The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. The EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10-2013.

2 Support equipment, if needed, was placed as per ANSI C63.10-2013

3 All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10-2013

4 The EUT received power from adapter, the adapter received AC120V/60Hz and AC 240V/60Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.

5 All support equipments received AC power from a second LISN, if any.

6 The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT.The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.

7 Analyzer / Receiver scanned from 150 KHz to 30MHz for emissions in each of the test modes.

8 During the above scans, the emissions were maximized by cable manipulation.

AC Power Conducted Emission Limit

For intentional device, according to § 15.207(a) AC Power Conducted Emission Limits is as following :

Frequency range (MHz)	Limit (dBuV)				
Frequency range (MHz)	Quasi-peak	Average			
0.15-0.5	66 to 56*	56 to 46*			
0.5-5	56	46			
5-30	60	50			
* Dearage a with the lease the of the freque					

* Decreases with the logarithm of the frequency.

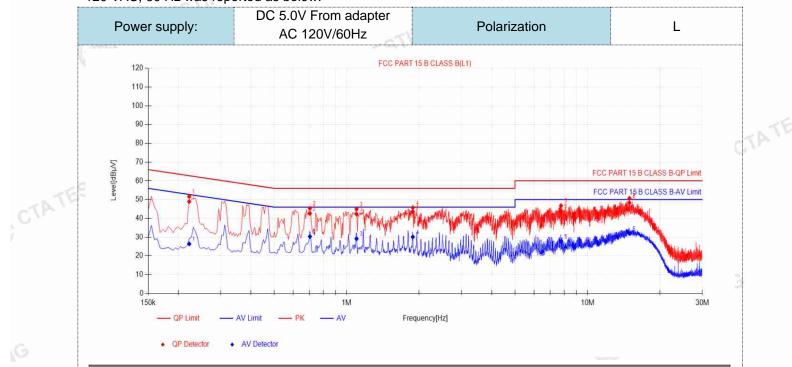
TEST RESULTS

Remark:

1. All modes of GFSK, Π/4 DQPSK and 8DPSK were test at Low, Middle, and High channel; only the worst result of GFSK Middle Channel was reported as below:

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Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn 2. Both 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz power supply have been tested, only the worst result of 120 VAC, 60 Hz was reported as below:



Final Data List

NO.	Freq. [MHz]	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Reading [dBµV]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]	Verdict
1	0.222	10.03	38.91	48.94	62.74	13.80	16.36	26.39	52.74	26.35	PASS
2	0.7035	9.91	32.71	42.62	56.00	13.38	20.40	30.31	46.00	15.69	PASS
3	1.0995	9.91	32.36	42.27	56.00	13.73	19.27	29.18	46.00	16.82	PASS
4	1.8825	9.92	33.78	43.70	56.00	12.30	20.20	30.12	46.00	15.88	PASS
5	7.764	10.28	33.59	43.87	60.00	16.13	17.36	27.64	50.00	22.36	PASS
6	14.9325	10.31	37.96	48.27	60.00	11.73	21.67	31.98	50.00	18.02	PASS
	1).QP Valu	· · /		•	• •	•					Ga
2 N.S.N.	actor (dB)=i			、 ,		•)				
3) OI	DMarain/dB	1 - ODI	imit (dRu	V = OD	h) auleV	Ru\/)					

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). QPMargin(dB) = QP Limit (dB μ V) QP Value (dB μ V)

CTA CTA

4). AVMargin(dB) = AV Limit (dB μ V) - AV Value (dB μ V)

GA CTATESTING

3

4

5

6

1.8825

3.3765

7.053

15.513

10.18

10.20

10.43

10.43

27.78

26.37

27.79

34.09

Note:1).QP Value (dBµV)= QP Reading (dBµV)+ Factor (dB) 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB) 3). QPMargin(dB) = QP Limit (dB μ V) - QP Value (dB μ V)

AVMargin(dB) = AV Limit (dBµV) - AV Value (dBµV)

G CTA TESTING

37.96

36.57

38.22

44.52

56.00

56.00

60.00

60.00

18.04

19.43

21.78

15.48

12.27

9.43

13.68

17.49

22.45

19.63

24.11

27.92

46.00

46.00

50.00

50.00

23.55

26.37

25.89

22.08

PASS

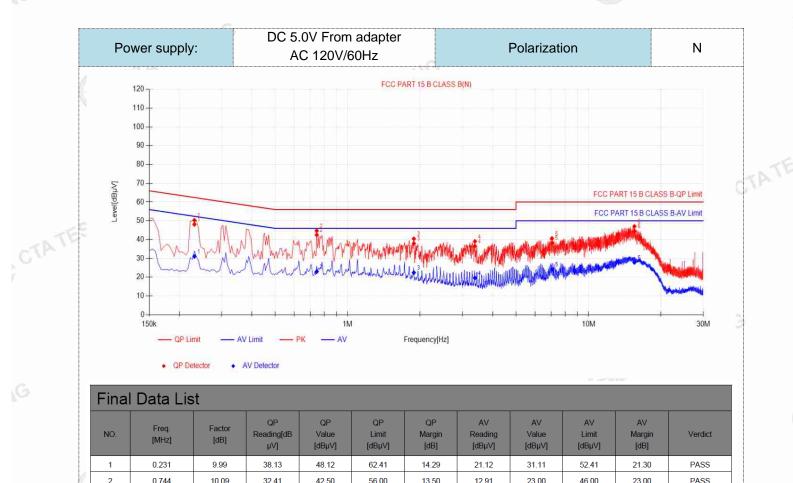
PASS

PASS

PASS

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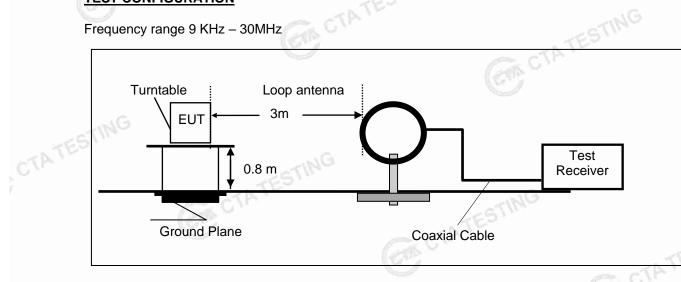


GA CTATESTING

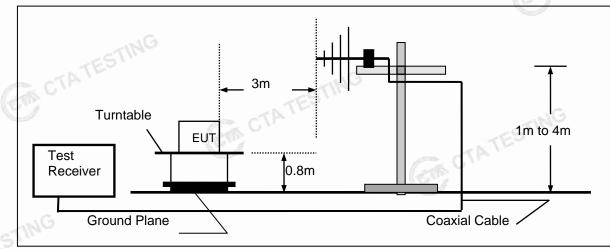
4.2 **Radiated Emission**

TEST CONFIGURATION

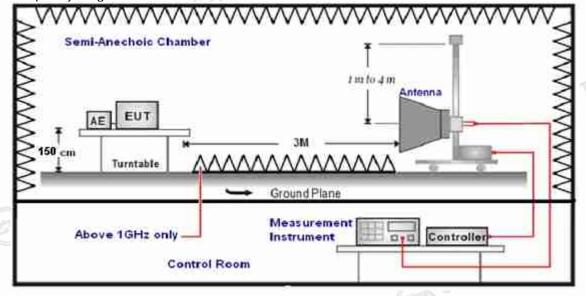




Frequency range 30MHz - 1000MHz



Frequency range above 1GHz-25GHz



6.

TEST PROCEDURE

- 1. The EUT was placed on a turn table which is 0.8m above ground plane when testing frequency range 9 KHz -1GHz; the EUT was placed on a turn table which is 1.5m above ground plane when testing frequency range 1GHz - 25GHz.
- 2. Maximum procedure was performed by raising the receiving antenna from 1m to 4m and rotating the turn table from 0° to 360° to acquire the highest emissions from EUT.
- 3. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- Repeat above procedures until all frequency measurements have been completed. 4.
- Radiated emission test frequency band from 9KHz to 25GHz. 5.

. The distance between test antenna and EUT as following table states:								
	Test Frequency range	Test Antenna Type	Test Distance					
	9KHz-30MHz	Active Loop Antenna	3					
	30MHz-1GHz	Ultra-Broadband Antenna	3					
	1GHz-18GHz	Double Ridged Horn Antenna	3					
	18GHz-25GHz	Horn Anternna	1					

Setting test receiver/spectrum as following table states: 7.

Setting test receiver/spectrum as following table states.								
Test Frequency range	Test Receiver/Spectrum Setting	Detector						
9KHz-150KHz	RBW=200Hz/VBW=3KHz,Sweep time=Auto	QP						
150KHz-30MHz	RBW=9KHz/VBW=100KHz,Sweep time=Auto	QP						
30MHz-1GHz	RBW=120KHz/VBW=1000KHz,Sweep time=Auto	QP						
1GHz-40GHz	Peak Value: RBW=1MHz/VBW=3MHz, Sweep time=Auto Average Value: RBW=1MHz/VBW=10Hz, Sweep time=Auto	Peak						

Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor(if any) from the measured reading. The basic equation with a sample calculation is as follows:

FS = RA + AF + CL - AG

	II SPUINS	
Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Los	s)
RA = Reading Amplitude	AG = Amplifier Gain	0
AF = Antenna Factor		Carry -

Transd=AF +CL-AG

RADIATION LIMIT

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emission from intentional radiators at a distance of 3 meters shall not exceed the following table. According to § 15.247(d), in any 100kHz bandwidth outside the frequency band in which the EUT is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the100kHz bandwidth within the band that contains the highest level of desired power.

The pre-test have done for the EUT in three axes and found the worst emission at position shown in test setup photos.

Frequency (MHz)	Distance (Meters)	Radiated (dBµV/m)	Radiated (µV/m)
0.009-0.49	3	20log(2400/F(KHz))+40log(300/3)	2400/F(KHz)
0.49-1.705	3	20log(24000/F(KHz))+ 40log(30/3)	24000/F(KHz)
1.705-30	3	20log(30)+ 40log(30/3)	30
30-88	3	40.0	100
88-216	3	43.5	150
216-960	3	46.0	200
Above 960	3	54.0	500

TATE

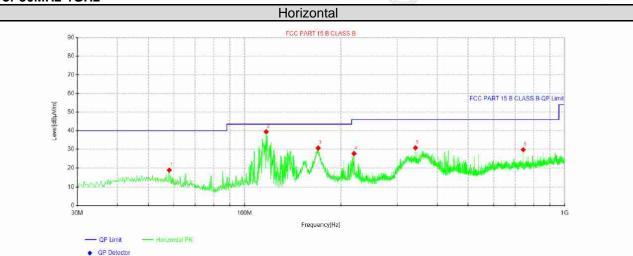
TEST RESULTS

Remark:

CTATE

- This test was performed with EUT in X, Y, Z position and the worse case was found when EUT in X 1. position.
- 2. We measured Radiated Emission at GFSK, π/4 DQPSK and 8DPSK mode from 9 KHz to 25GHz and recorded worst case at GFSK DH5 mode.
- 3. For below 1GHz testing recorded worst at GFSK DH5 middle channel.
- Radiated emission test from 9 KHz to 10th harmonic of fundamental was verified, and no emission found 4. except system noise floor in 9 KHz to 30MHz and not recorded in this report.





Suspected Data List

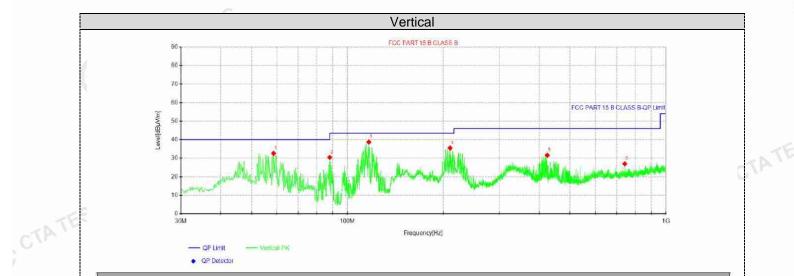
Suspected Data List											
NO.	Freq. [MHz]	Reading [dBµV]	Level [dBµV/m]	Factor [dB/m]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity		
1	58.13	31.12	18.81	-12.31	40.00	21.19	100	355	Horizontal		
2	116.815	53.14	39.42	-13.72	43.50	4.08	100	16 <mark>1</mark>	Horizontal		
3	169.801	45.66	30.65	-15. <mark>0</mark> 1	43.50	12.85	100	194	Horizontal		
4	219.756	40.20	27.72	-12.48	46.00	18.28	100	67	Horizontal		
5	341.855	41.52	30.77	-10.75	46.00	15.23	100	3	Horizontal		
6	742.586	34.76	29.79	-4.97	46.00	16.21	100	126	Horizontal		

Note:1).Level (dBµV/m)= Reading (dBµV)+ Factor (dB/m)

2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) - Pre Amplifier gain (dB)

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3). Margin(dB) = Limit (dB μ V/m) - Level (dB μ V/m) CTA TESTING



Suspected Data List

NO.	Freq. [MHz]	Reading [dBµV]	Level [dBµV/m]	Factor [dB/m]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	58.615	45.04	32.61	-12.43	40.00	7.39	100	326	Vertical
2	87.9575	45.62	30.46	-15.16	40.00	9.54	100	270	Vertical
3	116.693	52.44	38.72	-13.72	43.50	4.78	100	201	Vertical
4	210.056	48.22	35.48	-12.74	43.50	8.02	100	2	Vertical
5	423.941	41.53	31.62	-9.91	46.00	14.38	100	291	Vertical
6	742.586	31.96	26.99	-4.97	46.00	19.01	100	258	Vertical

CON CTATE

Note:1).Level (dBµV/m)= Reading (dBµV)+ Factor (dB/m)

2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) - Pre Amplifier gain (dB)

3). Margin(dB) = Limit (dB μ V/m) - Level (dB μ V/m)

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For 1GHz to 25GHz

Note: GFSK , π/4 DQPSK and 8DPSK all have been tested, only worse case GFSK is reported. GFSK (above 1GHz)

Frequency(MHz):			2402		Polarity:		HORIZONTAL			
Frequency (MHz)	_	ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4804.00	61.93	PK	74	12.07	66.20	32.33	5.12	41.72	-4.27	
4804.00	45.19	AV	54	8.81	49.46	32.33	5.12	41.72	-4.27	
7206.00	53.72	PK	74	20.28	54.24	36.6	6.49	43.61	-0.52	
7206.00	43.28	AV	54	10.72	43.80	36.6	6.49	43.61	-0.52	

Freque	Frequency(MHz):			2402		Polarity:		VERTICAL		
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4804.00	60.33	PK	74	13.67	64.60	32.33	5.12	41.72	-4.27	
4804.00	43.01	AV	54	10.99	47.28	32.33	5.12	41.72	-4.27	
7206.00	52.09	PK	74	21.91	52.61	36.6	6.49	43.61	-0.52	
7206.00	41.31	AV	54	12.69	41.83	36.6	6.49	43.61	-0.52	

Freque	Frequency(MHz):		2441		Polarity:		HORIZONTAL		
Frequency (MHz)	Emis Lev (dBu)	/el	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4882.00	61.21	PK	74	12.79	65.09	32.6	5.34	41.82	-3.88
4882.00	44.59	AV	54	9.41	48.47	32.6	5.34	41.82	-3.88
7323.00	52.97	PK	74	21.03	53.08	36.8	6.81	43.72	-0.11
7323.00	42.57	AV	54	11.43	42.68	36.8	6.81	43.72	-0.11

Frequency(MHz):			2441		Polarity:		VERTICAL			
Frequency (MHz)	-	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4882.00	59.41	PK	74	14.59	63.29	32.6	5.34	41.82	-3.88	
4882.00	42.89	AV	54	11.11	46.77	32.6	5.34	41.82	-3.88	
7323.00	51.33	PK	74	22.67	51.44	36.8	6.81	43.72	-0.11	
7323.00	40.93	AV	54	13.07	41.04	36.8	6.81	43.72	-0.11	

Frequency(MHz):			2480		Polarity:		HORIZONTAL		
Frequency (MHz)	-	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	60.61	PK	74	13.39	63.69	32.73	5.66	41.47	-3.08
4960.00	44.07	AV	54	9.93	47.15	32.73	5.66	41.47	-3.08
7440.00	52.39	PK	74	21.61	51.94	37.04	7.25	43.84	0.45
7440.00	41.83	PK	54	12.17	41.38	37.04	7.25	43.84	0.45

Frequency(MHz):			2480		Polarity:		VERTICAL			
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4960.00	58.82	PK	74	15.18	61.90	32.73	5.66	41.47	-3.08	
4960.00	42.40	AV	54	11.60	45.48	32.73	5.66	41.47	-3.08	
7440.00	50.59	PK	74	23.41	50.14	37.04	7.25	43.84	0.45	
7440.00	40.19	PK	54	13.81	39.74	37.04	7.25	43.84	0.45	

REMARKS:

- 1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)
- 2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier
- 3. Margin value = Limit value- Emission level.
- 4. -- Mean the PK detector measured value is below average limit.
- 5. The other emission levels were very low against the limit.

Results of Band Edges Test (Radiated)

Note: GFSK, π/4 DQPSK and 8DPSK all have been tested, only worse case GFSK is reported. GESK

				GFS	SK S				
Freque	ncy(MHz)	:	24	02	Pola	arity:	н	ORIZONTA	AL.
Frequency (MHz)		sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2390.00	61.53	PK	74	12.47	71.95	27.42	4.31	42.15	-10.42
2390.00	42.93	AV	54	11.07	53.35	27.42	4.31	42.15	-10.42
Frequency(MHz):		2402		Pola	Polarity:		VERTICAL		
Frequency (MHz)	Emis Le ^v (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2390.00	59.15	PK	74	14.85	69.57	27.42	4.31	42.15	-10.42
2390.00	41.38	AV	54	12.62	51.80	27.42	4.31	42.15	-10.42
Freque	ncy(MHz)):	2480		Pola	arity:	HORIZONTAL		
Frequency (MHz)	Emis Le ^v (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2483.50	60.87	PK	74	13.13	70.98	27.7	4.47	42.28	-10.11
2483.50	42.18	AV	54	11.82	52.29	27.7	4.47	42.28	-10.11
Freque	ncy(MHz)	:	24	80	Pola	arity:		VERTICAL	
Frequency (MHz)	Emis Le ^v (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2483.50	58.93	ΡK	74	15.07	69.04	27.7	4.47	42.28	-10.11
2483.50	40.18	AV	54	13.82	50.29	27.7	4.47	42.28	-10.11
DEMADKO	•.							1	101 11

REMARKS:

1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)

2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier

3. Margin value = Limit value- Emission level.

CTA TESTING 4. -- Mean the PK detector measured value is below average limit.

5. The other emission levels were very low against the limit.

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Maximum Peak Output Power 4.3

Limit -

The Maximum Peak Output Power Measurement is 125mW (20.97).

Test Procedure

Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to CON CTATE the powersensor.

Test Configuration CTATESTING



Test Results

Channel	Output power (dBm)	Limit (dBm)	Result
	4.07		265V
00	1.07		ATE
39	0.37	20.97	Pass
78	0.36		
00	0.41		
39	-0.20	20.97	Pass
78	-0.24		
00	0.53	TING	
39	-0.07	20.97	Pass
78	-0.30	CIM	
ults including the	cable lose.	1	Ca
	39 78 00 39 78 00 39 78 00 39 78 78 78 00 39 78 00 39 78	39 0.37 78 0.36 00 0.41 39 -0.20 78 -0.24 00 0.53 39 -0.07	39 0.37 20.97 78 0.36 20.97 00 0.41 20.97 39 -0.20 20.97 78 -0.24 20.97 00 0.53 20.97 39 -0.07 20.97 78 -0.30 20.97

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20dB Bandwidth 4.4

Limit

For frequency hopping systems operating in the 2400MHz-2483.5MHz no limit for 20dB bandwidth.

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with 30 KHz RBW and 100 KHz VBW.

The 20dB bandwidth is defined as the total spectrum the power of which is higher than peak power minus 20dB.

Test Configuration



Test Results

<u>Test Results</u>			CTATESTI
Modulation	Channel	20dB bandwidth (MHz)	Result
NG	CH00	0.957	
GFSK	CH39	0.933	
CITA	CH78	0.954	
9	CH00	1.305	-SG
π/4DQPSK	CH39	1.278	Pass
	CH78	1.317	1
	CH00	1.302	
8DPSK	CH39	1.305	Ca
G	CH78	1.281	C.

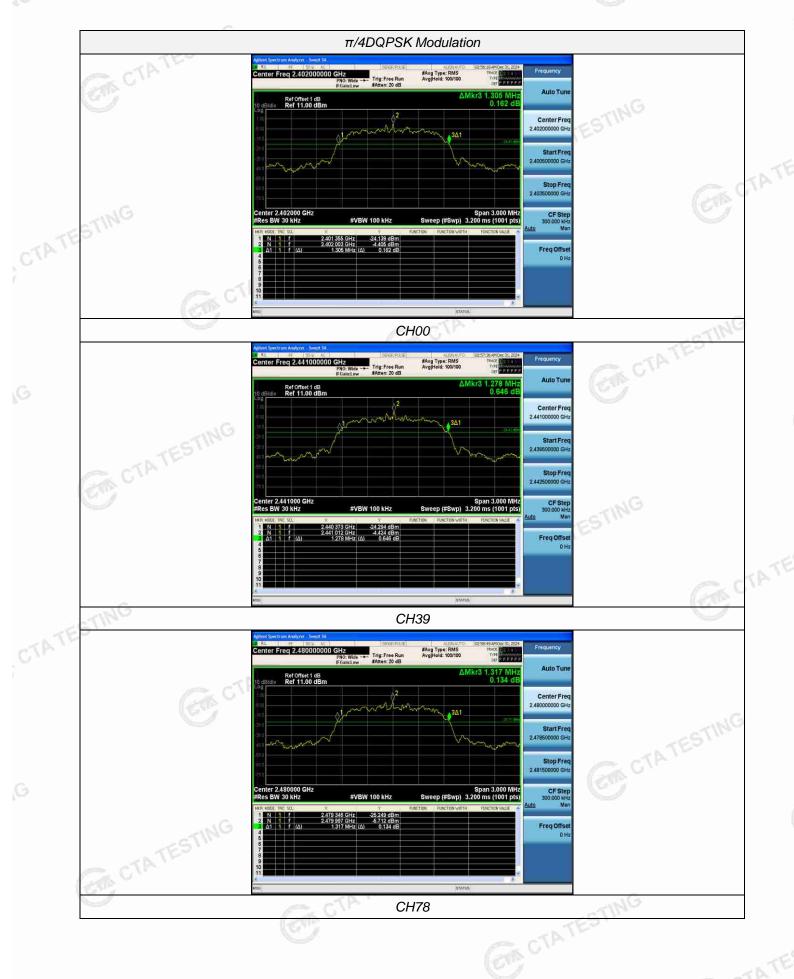
Test plot as follows:

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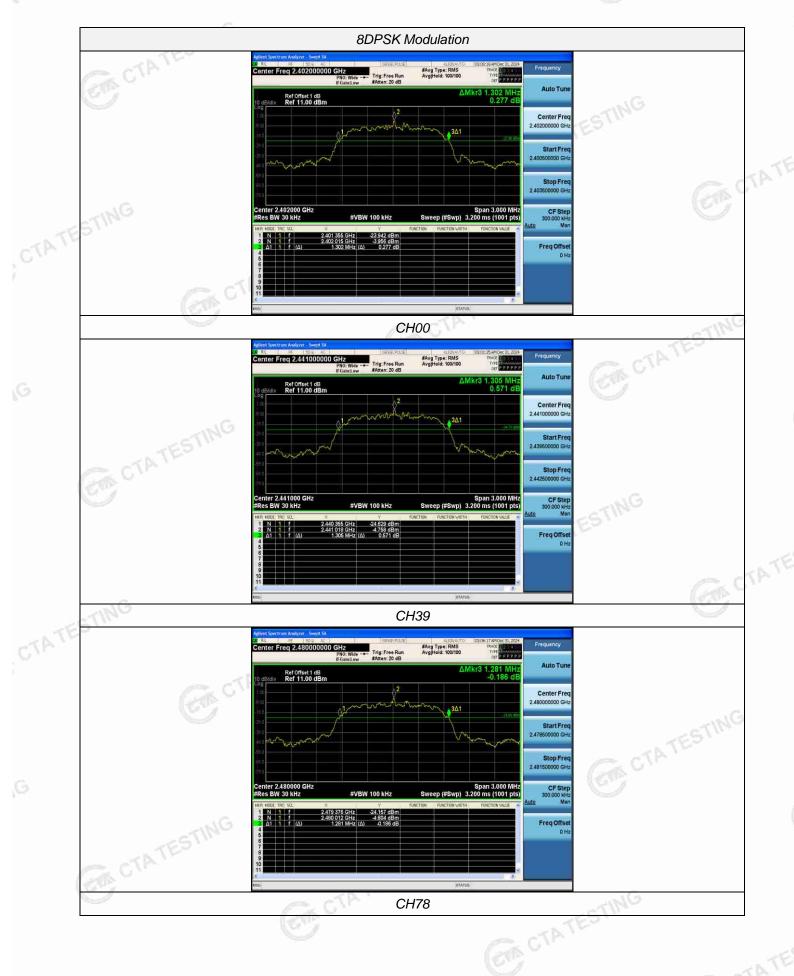












4.5 Frequency Separation

LIMIT

According to 15.247(a)(1), frequency hopping systems shall have hopping channel carrier frequencies separated by minimum of 25KHz or the 2/3*20dB bandwidth of the hopping channel, whichever is greater.

TEST PROCEDURE

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with100 KHz RBW and 300 KHz VBW.

TEST CONFIGURATION



TEST RESULTS

Modulation	Channel	Channel Separation (MHz)	Limit(MHz)	Result
GFSK	CH38	1.004	25KHz or 2/3*20dB	Pass
Grok	CH39	1.004	bandwidth	Fd55
	CH38	1.100	25KHz or 2/3*20dB	Pass
π/4DQPSK	CH39	1.100	bandwidth	Fass
ADD6K	CH38	1 190	25KHz or 2/3*20dB	Pass
8DPSK	CH39	1.180	bandwidth	Pass

Note:

We have tested all mode at high, middle and low channel, and recorded worst case at middle

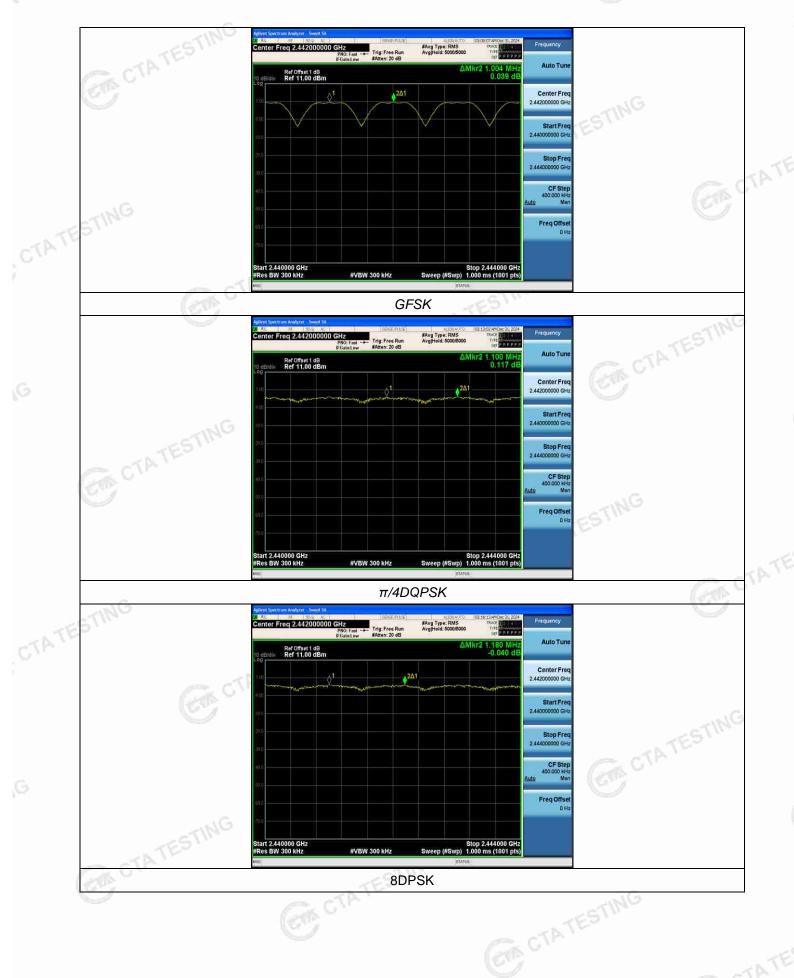
Test plot as follows:

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Number of hopping frequency 4.6

Limit C

Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels.

Test Procedure

CTA TE The transmitter output was connected to the spectrum analyzer through an attenuator. Set spectrum analyzer start 2400MHz to 2483.5MHz with 100 KHz RBW and 300 KHz VBW.

Test Configuration CTATES



Test Results

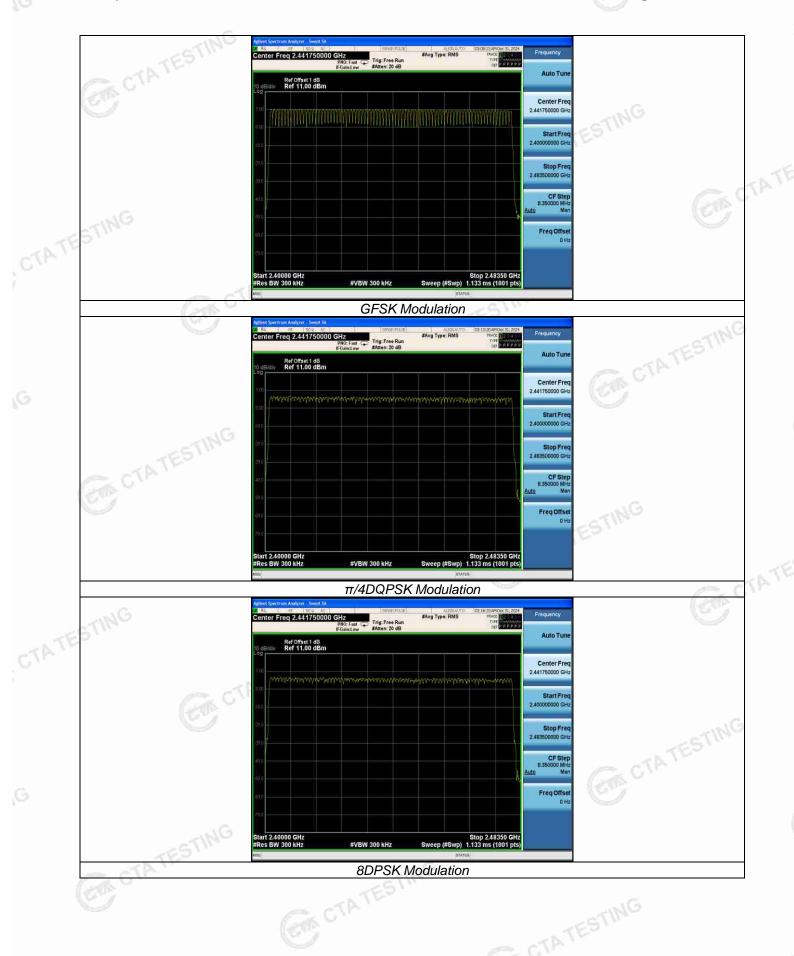
			1 - C - C - C - C - C - C - C - C - C -
Modulation	Number of Hopping Channel	Limit	Result
GFSK	79	(81	6
π/4DQPSK	79	≥15	Pass
8DPSK	79		
Test plot as follows:	COM CTATESTING	CTATEST	NG

Test plot as follows:

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Time of Occupancy (Dwell Time) 4.7

Limit

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. Set center frequency of spectrum analyzer=operating frequency with 1MHz RBW and 1MHz VBW, Span 0Hz.

Test Configuration



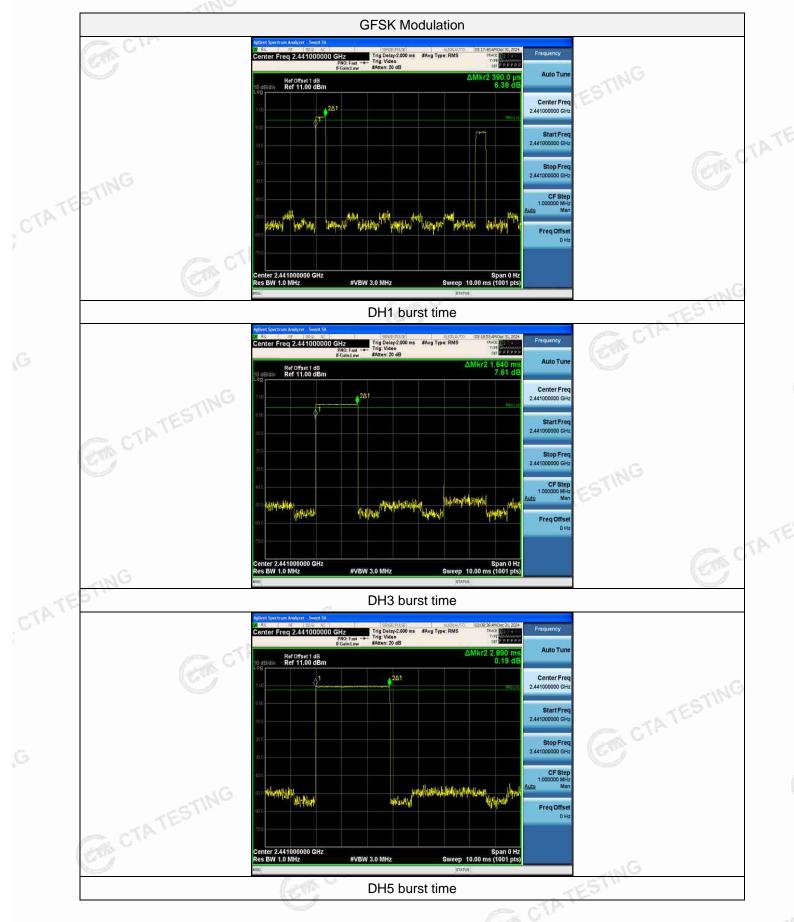
Test Results

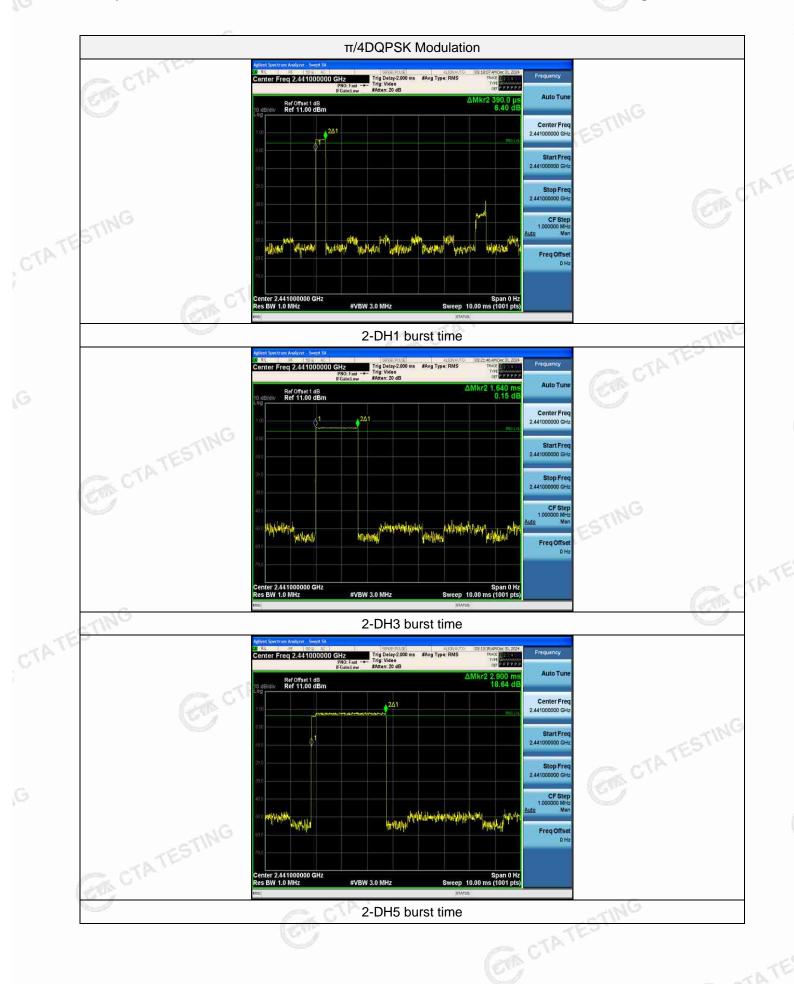
		(W	1		-A THE
Modulation	Packet	Burst time (ms)	Dwell time (s)	Limit (s)	Result
	DH1	0.390	0.125		
GFSK	DH3	1.640	0.262	0.40	Pass
TATES	DH5	2.890	0.308		
Garcin	2-DH1	0.390	0.125		
π/4DQPSK	2-DH3	1.640	0.262	0.40	Pass
	2-DH5	2.900	0.309	TESI	
	3-DH1	0.390	0.125	CTR	
8DPSK	3-DH3	1.640	0.262	0.40	Pass
	3-DH5	2.900	0.309		Gan

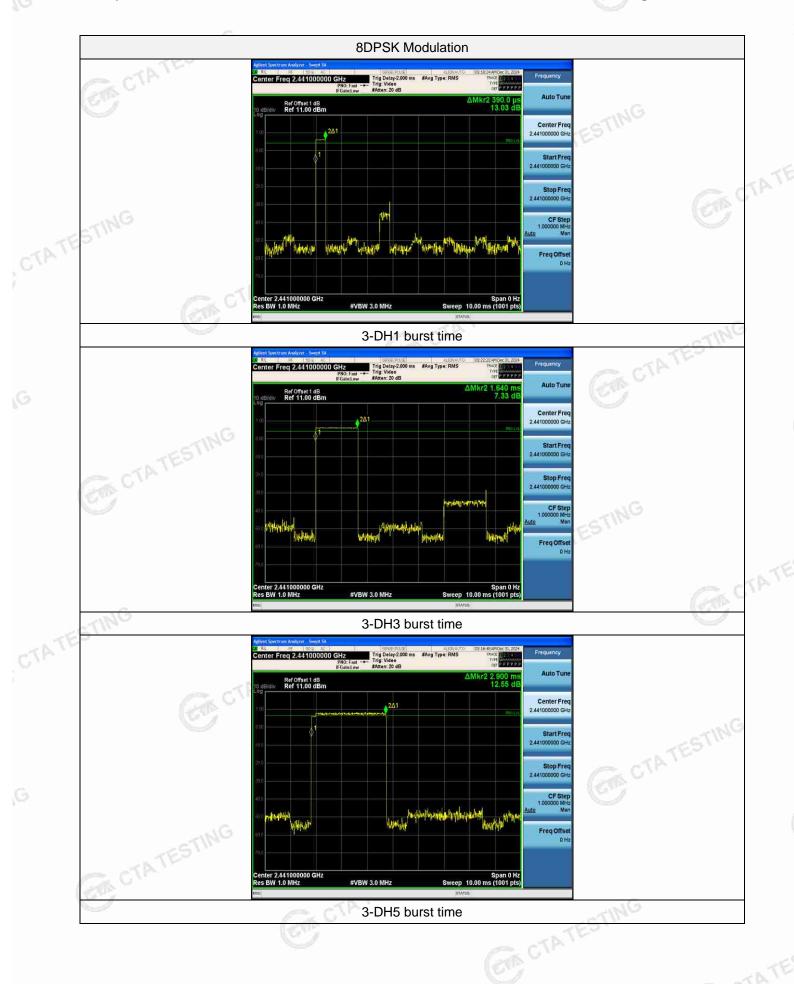
Note:We have tested all mode at high, middle and low channel, and recoreded worst case at middle channel. Dwell time=Pulse time (ms) x (1600 ÷ 2 ÷ 79) x31.6 Second for DH1, 2-DH1, 3-DH1 Dwell time=Pulse time (ms) \times (1600 \div 4 \div 79) \times 31.6 Second for DH3, 2-DH3, 3-DH3 Dwell time=Pulse time (ms) x (1600 ÷ 6 ÷ 79) x31.6 Second for DH5, 2-DH5, 3-DH5 GTA CTA TESTING

GTA TESTING

Test plot as follows:







Out-of-band Emissions 4.8

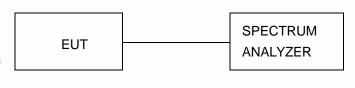
Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, pro-vided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter com-plies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required.

Test Procedure

Connect the transmitter output to spectrum analyzer using a low loss RF cable, and set the spectrum analyzer to RBW=100 kHz, VBW= 300 kHz, peak detector, and max hold. Measurements utilizing these setting are CON CTATESTING made of the in-band reference level, bandedge and out-of-band emissions.

Test Configuration



Test Results

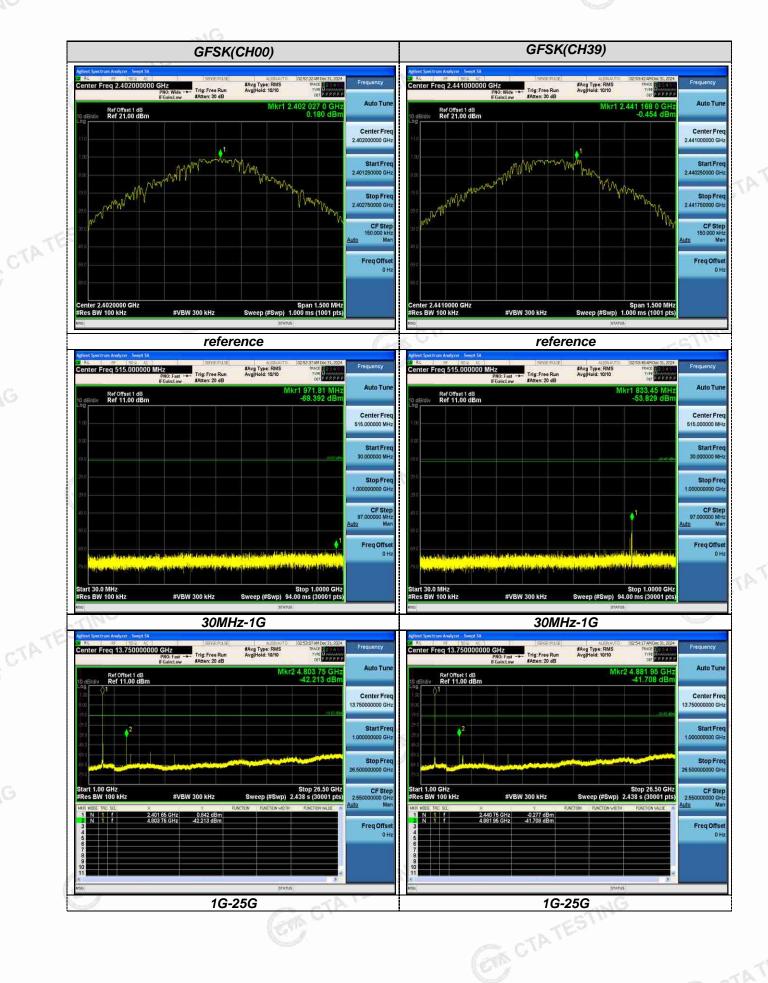
Remark: The measurement frequency range is from 30MHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandage measurement data.

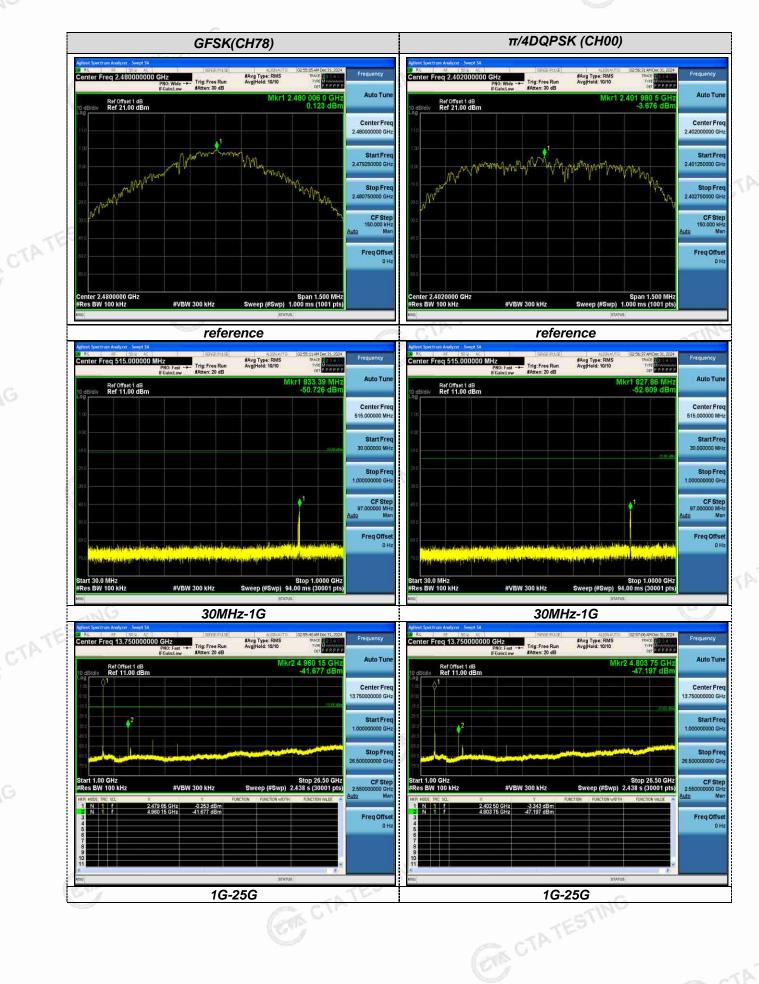
We measured all conditions (DH1, DH3, DH5) and recorded worst case at DH5

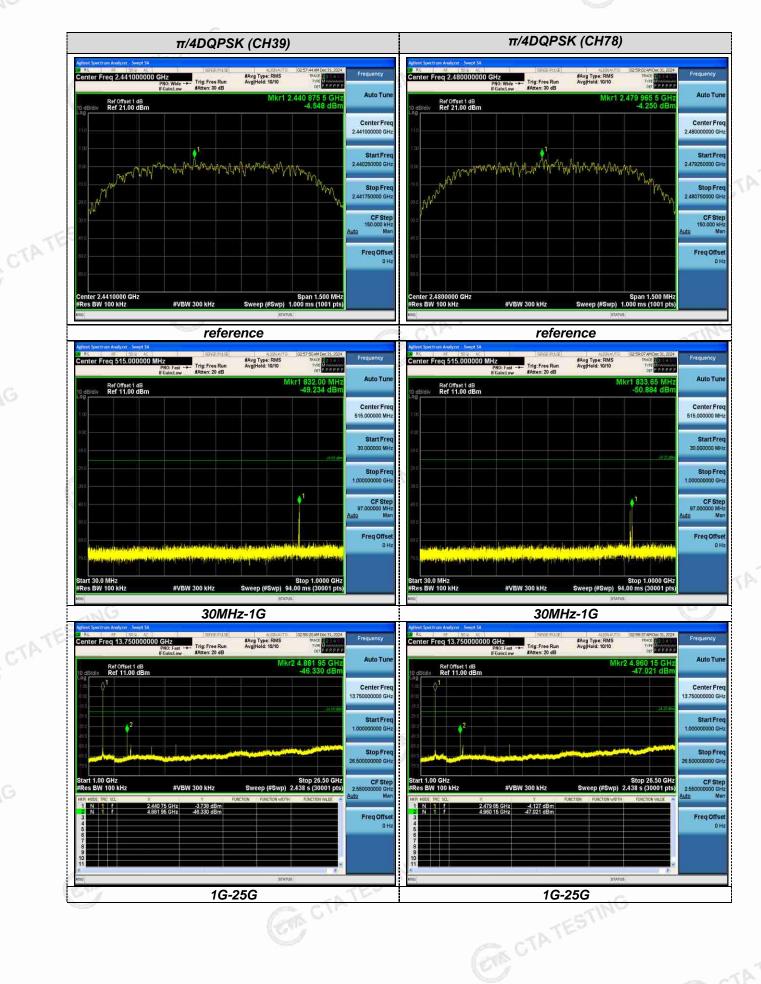
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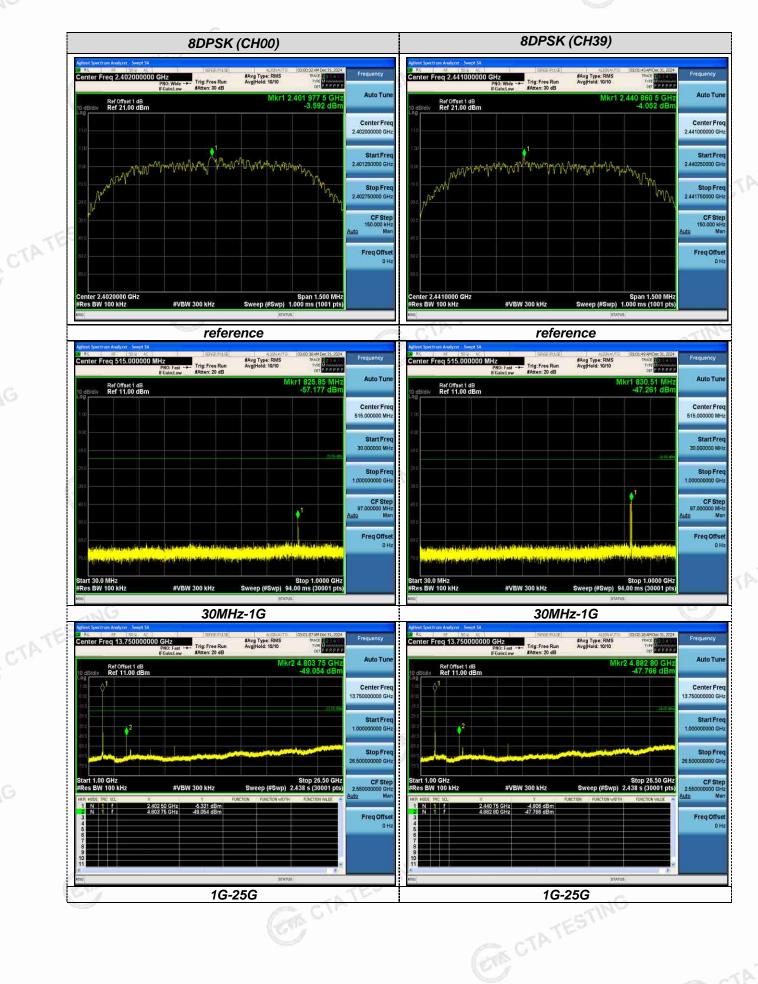
Test plot as follows:

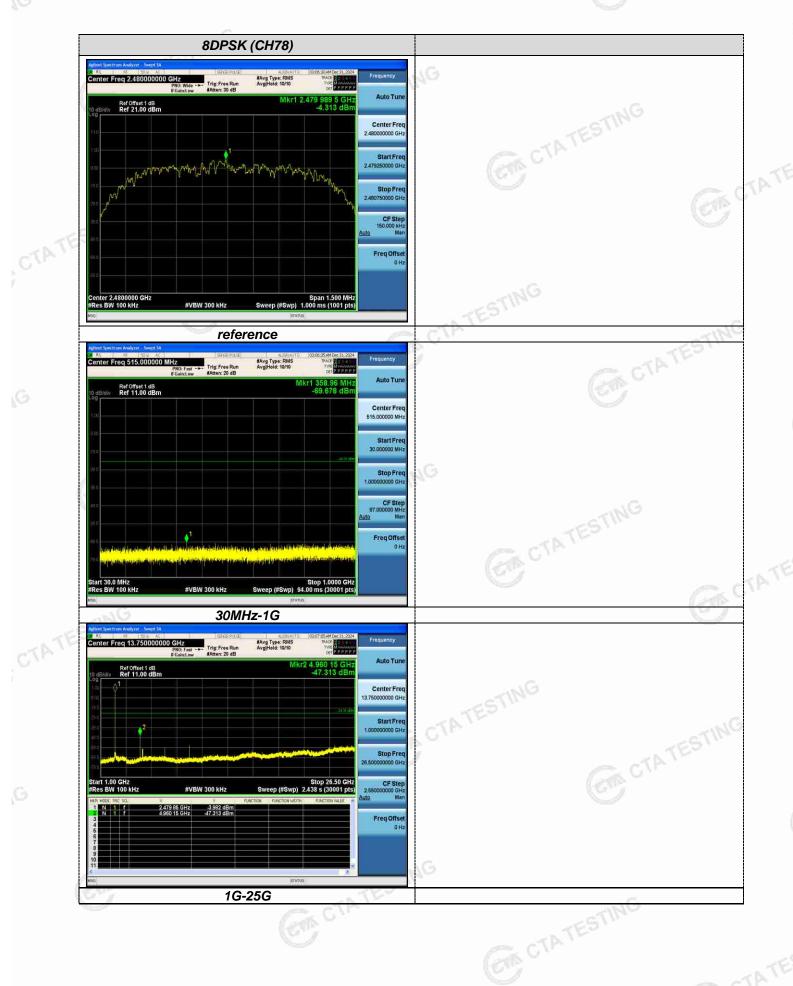
GTA CTA TESTING

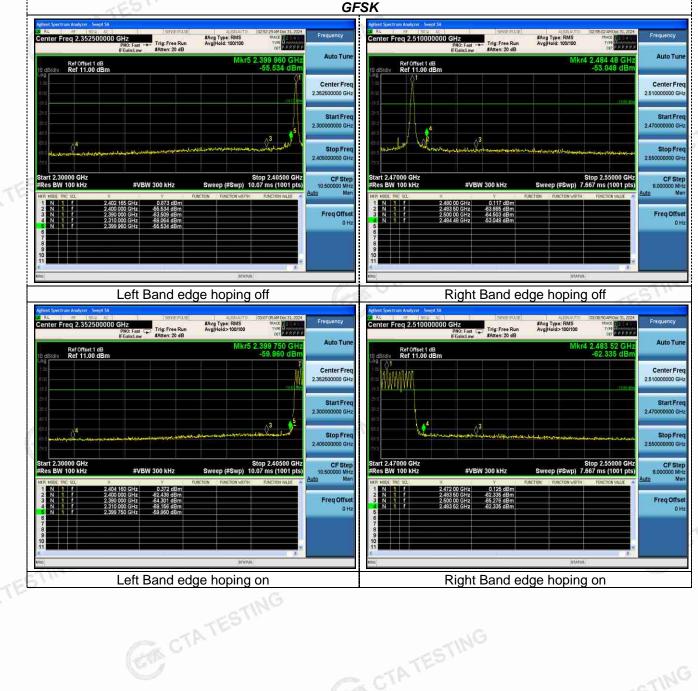












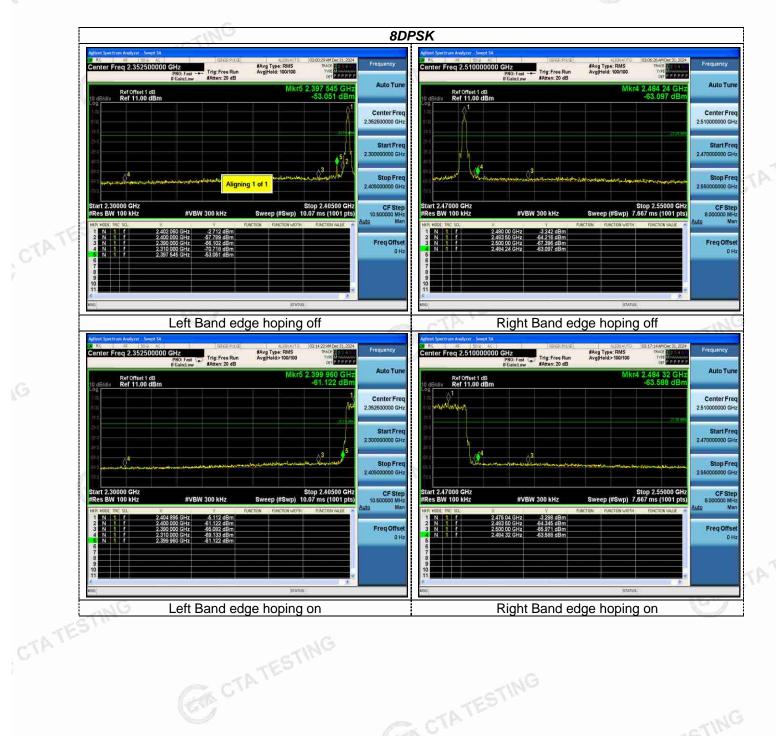
Band-edge Measurements for RF Conducted Emissions:

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Pseudorandom Frequency Hopping Sequence 4.9

TEST APPLICABLE

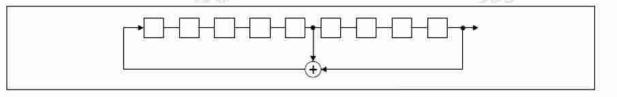
For 47 CFR Part 15C section 15.247 (a) (1) requirement:

Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hop-ping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400–2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW. The system shall hop to channel frequencies that are selected at the system hopping rate from a pseudo randomly ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hop-ping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

EUT Pseudorandom Frequency Hopping Sequence Requirement

The pseudorandom frequency hopping sequence may be generated in a nice-stage shift register whose 5th and 9th stage outputs are added in a modulo-two addition stage. And the result is fed back to the input of the first stage. The sequence begins with the first one of 9 consecutive ones, for example: the shift register is initialized with nine ones.

- Number of shift register stages:9
- Length of pseudo-random sequence:29-1=511 bits
- Longest sequence of zeros:8(non-inverted signal)



Linear Feedback Shift Register for Generation of the PRBS sequence

An example of pseudorandom frequency hopping sequence as follows:

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Each frequency used equally one the average by each transmitter.

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The system receiver have input bandwidths that match the hopping channel bandwidths of their corresponding transmitter and shift frequencies in synchronization with the transmitted signals.

4.10 Antenna Requirement

Standard Applicable

For intentional device, according to FCC 47 CFR Section 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

And according to FCC 47 CFR Section 15.247 (c), if transmitting antennas of directional gain greater than 6dBi are used, the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6dBi.

Refer to statement below for compliance

The manufacturer may design the unit so that the user can replace a broken antenna, but the use of a standard antenna jack or electrical connector is prohibited. Further, this requirement does not apply to intentional radiators that must be professionally installed.

Antenna Connected Construction

The maximum gain of antenna was 0.88 dBi

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Remark:The antenna gain is provided by the customer , if the data provided by the customer is not accurate, Shenzhen CTA Testing Technology Co., Ltd. does not assume any responsibility.

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5 Test Setup Photos of the EUT







External and Internal Photos of the EUT 6



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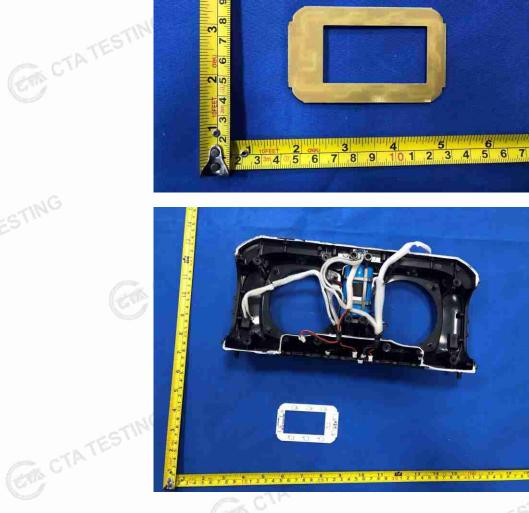
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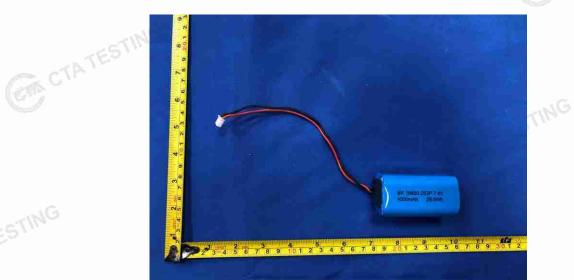
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BR 18650-2S2P 7.4V 4000mAh 29.6Wh

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